## Search Notes



NPL: ACM database search, attached

NPL: Google Scholar search, attached

NPL:IEEE database search , attached

NPL: ACM database search, attached

NPL: Google Scholar search, attached

NPL:IEEE database search , attached

EAST (EPO: JPO: IBM: USPAT: USPGPUB), attached

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Applicant(s)/Patent Under Reexamination

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Art Unit

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## SEARCHED

Class	Subclass	Date	Examiner
707	3	10/20/2008	DM
707	3, 100, 104.1	2/27/2009	DM
707	3, 104.1	9/10/2009	DM

**SEARCH NOTES** 

Search Notes	Date	Examiner
EAST (EPO; JPO; IBM; USPAT; USPGPUB), attached	03/03/2008	DM
EAST (EPO; JPO; IBM; USPAT; USPGPUB), attached	03/19/2008	DM
707/3 limited with keywords	03/03/2008	DM
PALM Inventor search	03/03/2008	DM
NPL:IEEE database search , attached	03/03/2008	DM
NPL: ACM database search , attached	03/03/2008	DM
NPL: Google Scholar search , attached	03/03/2008	DM
EAST (EPO; JPO; IBM; USPAT; USPGPUB), attached	10/20/2008	DM
NPL: ACM database search , attached	10/20/2008	DM
NPL: Google Scholar search , attached	10/20/2008	DM
EAST (EPO; JPO; IBM; USPAT; USPGPUB), attached	2/27/2009	DM

		INTERFERENCE SE	ARCH	
Class		Subclass	Date	Examiner
707	104.1		9/10/2009	DM

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